


<b>Search Notes</b>  	<b>Application/Control No.</b>  10530751	<b>Applicant(s)/Patent Under Reexamination</b>  HAGIHARA ET AL.
	<b>Examiner</b>  SPENCER PATTON	<b>Art Unit</b>  3664

SEARCHED			
Class	Subclass	Date	Examiner
700	245, 250, 262	1/24/2010	/SP/
318	700, 400.42	1/24/2010	/SP/

SEARCH NOTES		
Search Notes	Date	Examiner
EAST search history printout attached	1/24/2010	/SP/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/SPENCER PATTON/ Examiner.Art Unit 3664	
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